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Electron-assisted synthesis of g-C₃N₄/MoS₂ composite with dual defects for enhanced visible-light-driven photocatalysis

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g-C₃N₄/MoS₂ composites were successfully prepared by an electron-assisted strategy in one step. Dielectric barrier discharge (DBD) plasma as an electron source, which has low bulk temperature and high electron energy, can etch and modify the surface of g-C₃N₄/MoS₂. The abundant N and S vacancies were introduced in the composites by plasma. The dual defects promoted the recombination and formation of heterojunctions of the g-C₃N₄/MoS₂ composite. It exhibited stronger light harvesting ability and higher charge separation efficiency than that of pure g-C₃N₄ and MoS₂. Compared with the sample by traditional calcination method, the plasma-sample showed better performance for degrading rhodamine B (RhB) and methyl orange. RhB is completely degraded within 2 hours on g-C₃N₄/MoS₂ by plasma. A mechanism for the photocatalytic degradation of organic pollutants *via* the composites was proposed. An electron-assisted strategy provides a green and effective platform to achieve catalysts with improved performance.

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Introduction

Due to the rapid development of industrialization, environmental pollution especially water pollution is becoming more and more serious. Various practical strategies have been developed for efficient removal of organic pollutants from wastewater.¹ The photocatalytic process shows great potential as a green, low cost and sustainable treatment technology in the wastewater industry.² Semiconductor mediated photocatalysis is a most used strategy, that has attracted great interest for the degradation of organic pollutants under solar radiation.

g-C₃N₄, as a visible light-responsive semiconductor material, is characterized by low cost, convenient preparation, unique structure, non-toxicity, and harmlessness.³ MoS₂, a layered material with a narrow band gap, is often used as a cocatalyst in various applications.⁴ Meanwhile, heterostructure materials have received extensive attention due to their unique physicochemical properties.⁵ Among them, the combination of g-C₃N₄ and MoS₂ in heterostructured photocatalysts could effectively improve the photocatalytic degradation of organic pollutants. Fan *et al.* prepared a 2D g-C₃N₄/MoS₂ composite by calcination and revealed that the composite shows good degradation activity for rhodamine B (RhB) and methyl orange (MO) under visible light.⁶ Chen *et al.* prepared a g-C₃N₄/MoS₂ composite by vacuum freeze drying and demonstrated that this composite

has good hydrogen production efficiency and pollutant degradation activity under visible light.⁷

Defect engineering can effectively improve the photochemical and electrocatalysis performance of semiconductor materials.⁸ A suitable concentration of defects can effectively reduce the recombination rate of electrons and holes, change the band gap structure, and enhance the light absorption capacity.⁹ Surface defects may also serve as physical adsorption or chemically active sites to improve photocatalytic reactions.¹⁰ Defect engineering can usually be achieved by chemical reduction method,¹¹ high-temperature hydrogen reduction,¹² and light reduction.¹³ Li *et al.* obtained WO₃ with oxygen vacancies that could be used for water oxidation reactions by hydrogen roasting at 500 °C.¹² Ye *et al.* prepared porous g-C₃N₄ by using 300 W Xe lamp heating combined with hydrazine reduction and applied the same to achieve hydrogen energy.¹³ Unfortunately, these synthesis methods usually feature long processing times, high energy consumption, and complicated processes. Therefore, applying the green, convenient, and fast method of new technology for catalyst preparation is an effective strategy.¹⁴

Among them, nonthermal plasma, which has a relatively low bulk temperature and extremely high electron temperature, has excellent advantages for preparing catalysts.¹⁵ Plasma can etch the surface of many materials and produce an abundance of defects. Defects of different concentrations can be prepared under different atmospheres and treatment times. For example, Wang *et al.* prepared Co₃O₄ with oxygen vacancies by using Ar plasma, the Co₃O₄ showed enhanced electrocatalytic oxygen evolution reaction performance.¹⁶ Feng *et al.* used dielectric

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barrier discharge (DBD) plasma to prepare TiO_2 with oxygen vacancies and better performance for the photocatalytic degradation of pollutants.¹⁷

In this paper, N and S vacancies enriched $\text{g-C}_3\text{N}_4/\text{MoS}_2$ composite was prepared using DBD plasma. X-ray diffraction (XRD), X-ray photoelectron spectroscopy (XPS), electron paramagnetic resonance (EPR), high-resolution transmission electron microscopy (HRTEM), and other characterization methods were used to analyze the physical and chemical properties of the composites. The vacancies and heterostructure of the composite ensure charge separation efficiency and strong light absorptive capacity. The photocatalytic performance of the composite was also tested by degrading RhB and MO under visible light. The strategy of producing defects by plasma can be applied to other nanosheet materials to enhance their photocatalytic performance.

Experimental

Materials

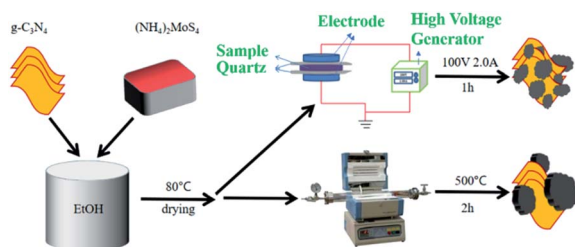
Melamine, ammonium tetrathiomolybdate, anhydrous ethanol, rhodamine B, triethanolamine were purchased from Shanghai Aladdin Biochemical Technology Co. All chemicals were used without further purification.

Synthesis of $\text{g-C}_3\text{N}_4$

The pure $\text{g-C}_3\text{N}_4$ powder was synthesized by heating melamine powder directly. Typically, 10 g melamine was putted into a closed alumina crucible, then heated at 550°C for 4 h with the rate of 5°C min^{-1} in the muffle furnace. The as-prepared yellow product was grounded for further use.

Synthesis of $\text{g-C}_3\text{N}_4/\text{MoS}_2$

The schematic illustration for the preparation of $\text{g-C}_3\text{N}_4/\text{MoS}_2$ composites can be seen from Scheme 1. First, 200 mg $\text{g-C}_3\text{N}_4$ powder was added to anhydrous ethanol under vigorous stirring, then $(\text{NH}_4)_2\text{MoS}_4$ was added to the suspension and stirred for 12 hours. Then the mixture was dried in an oven at 353 K overnight for 2 h to remove the residual ethanol in the sample. The sample was then split into two portions. One portion was to be treated by calcination (and the other portion by plasma). For traditional calcination, the sample was calcined 500°C at a rate of 5°C min^{-1} in air for 2 hours. The sample prepared this way was designated as MCX-C. X represents the weight ratio of MoS_2 in the composites.



Scheme 1 Schematic of the preparation of $\text{g-C}_3\text{N}_4/\text{MoS}_2$ composites.

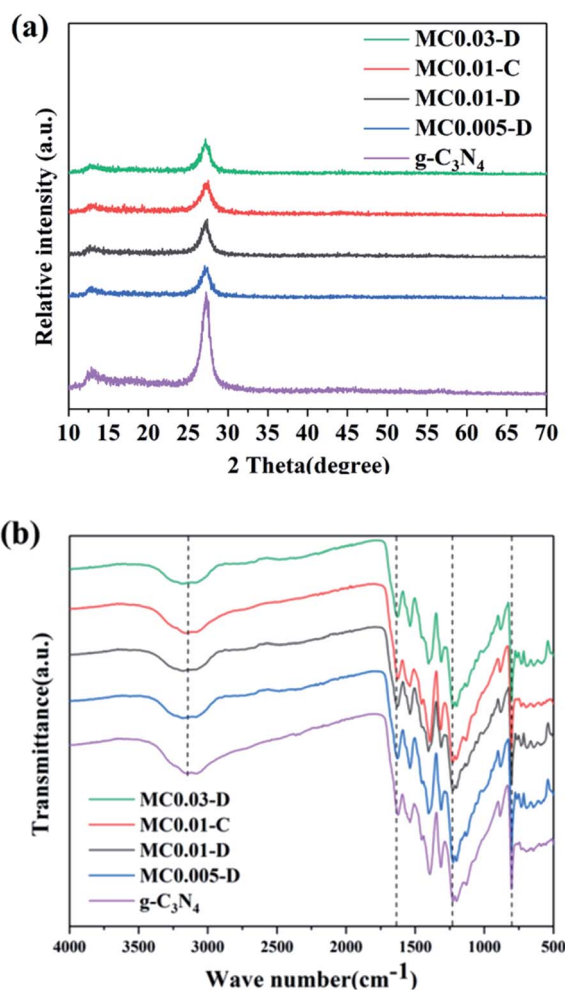


Fig. 1 (a) XRD and (b) FTIR patterns of $\text{g-C}_3\text{N}_4$ and $\text{g-C}_3\text{N}_4/\text{MoS}_2$ composites.

The other portion was treated by DBD plasma. The details of treatment using plasma have been described in the previous work.^{30,31} The sample (about 0.2 g) was loaded on a quartz reactor that was placed between two electrodes. It was generated by applying 100 V and 2.0 A with $\text{H}_2\text{-Ar}$ ($\text{H}_2/\text{Ar} = 1/9$ vol) as the plasma-forming gas. One-time plasma operation proceeded for 3 min to restrict the heat effect (IR camera shows the operation temperature is below 145°C), followed by manually stirring to expose the untreated sample outside. The operation was repeated for 20 times, until total plasma treatment time was 1 h. The obtained samples were named MCX-D.

The pure $\text{g-C}_3\text{N}_4$ and $(\text{NH}_4)_2\text{MoS}_4$ were also treated by plasma, and named $\text{g-C}_3\text{N}_4\text{-D}$ and $\text{MoS}_2\text{-D}$, respectively. $(\text{NH}_4)_2\text{MoS}_4$ was calcined 500°C at a rate of 5°C min^{-1} in air for 2 hours and named $\text{MoS}_2\text{-C}$.

Characterization

Rigaku D/Max-2500 V/PC diffractometer with $\text{Cu K}\alpha 1$ radiation ($\text{Cu K}\alpha 1 \lambda = 0.154 \text{ nm}$, 40 kV, 40 mA, 8°min^{-1}) was used to analyze the crystal phase of samples. Fourier transform infrared (FTIR) spectra was analyzed by Bruker Alpha FTIR-ATR



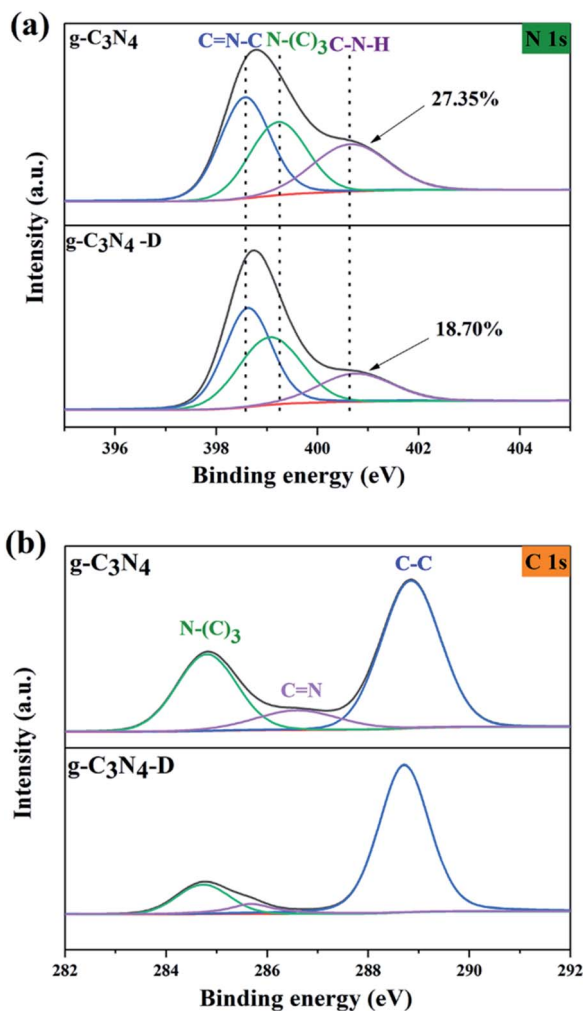


Fig. 2 High-resolution XPS spectra of the (a) N 1s and (b) C 1s of $g\text{-C}_3\text{N}_4$.

Table 1 C/N atomic ratios of $g\text{-C}_3\text{N}_4$ and MC0.01 samples

| Samples | Atomic ratio (C : N) | Peak area ratio: $S_{\text{C-N-H}}/S_{\text{total}}$ |
|-----------------------------------|----------------------|--|
| $g\text{-C}_3\text{N}_4$ | 0.921 | 0.273 |
| $g\text{-C}_3\text{N}_4\text{-D}$ | 0.954 | 0.187 |
| MC0.01-C | 0.969 | 0.225 |
| MC0.01-D | 0.976 | 0.202 |

instrument. A PHI-5000 VersaProbe instrument was used to obtain X-ray photoelectron spectra (XPS). The adventitious carbon C 1s used for element correction is located at 284.8 eV. Electron spin resonance (ESR) measurement was obtained on a Bruker A300 spectrometer at room temperature. The UV-vis diffuse-reflectance spectroscopy was recorded by a UV-2600 spectrophotometer. Photoluminescence (PL) spectroscopy was analyzed on F-4600 spectrometer with excitation at 350 nm. Scanning electron microscopy (SEM) and energy dispersive X-ray spectroscopy were conducted on S4800 instrument. High-

resolution transmission electron microscopy (TEM) and energy dispersive X-ray elemental mapping were conducted on FEI Tecnai G20.

Measurement of photocatalytic activity

RhB and MO degradation. 50 mg sample was added to 100 ml RhB solution or MO solution. First the entire suspension was adsorbed in a dark box for half an hour. 300 W Xe lamp was equipped with 420 nm filter as light source. 3 ml was sampled every 20 min or 30 min after starting the light. The samples were centrifuged to determine the degree of degradation by UV-2600 measurement.

Photoelectrochemical investigation. The photocurrent density was conducted at the LK2010 Electrochemical system. It is a traditional three-electrode system, thereof, FTO conductive glass loaded with sample as working electrode. Reference electrode and counter electrode are the saturated Ag/AgCl electrode and Pt wire, respectively. The 0.1 M Na_2SO_4 solution was used as electrolyte. Solar light was provided by 300 W Xe lamp equipped with AM1.5G and total reflection filter. At the beginning of the test, fully introducing N_2 into the electrolyte to remove dissolved oxygen. Black or light every 40 second.

Results and discussion

Fig. 1a shows the XRD spectra of the $g\text{-C}_3\text{N}_4$ and $g\text{-C}_3\text{N}_4/\text{MoS}_2$ composites. Peaks corresponding to the (100) and (002) crystal planes of pure $g\text{-C}_3\text{N}_4$ appeared at 13.2° and 27.5° , which are attributed to the structure of tri-s-triazine and conjugated aromatic system, respectively.¹⁸ The peak of MoS_2 was not observed in the XRD spectrum of the $g\text{-C}_3\text{N}_4/\text{MoS}_2$ composite due to the low concentration of MoS_2 . In addition, the peak strength of the composite was weaker than that of pure $g\text{-C}_3\text{N}_4$. It indicates that $g\text{-C}_3\text{N}_4$ was successfully etched by plasma and its crystal structure had been changed.

Fourier transform infrared (FTIR) analysis was performed to analyze the composition and chemical bond information of the samples. Fig. 1b shows the FTIR spectra of pure $g\text{-C}_3\text{N}_4$ and the $g\text{-C}_3\text{N}_4/\text{MoS}_2$ composite. The peak at 807 cm^{-1} in the spectrum of pure $g\text{-C}_3\text{N}_4$ is attributed to the tri-s-triazine unit structure. The four strong bands in the region of $1240\text{--}1640\text{ cm}^{-1}$ are attributed to the extension of the CN heterocyclic ring in $g\text{-C}_3\text{N}_4$.¹⁹ Vibrations between $3000\text{ and }3500\text{ cm}^{-1}$ are caused by N-H and -OH tensile vibrations.²⁰ No other changes were found in the composite. The FTIR results are consistent with the results observed by XRD.

The XPS spectra of $g\text{-C}_3\text{N}_4$ by plasma treatment are shown in Fig. 2. Fig. 2a shows the high-resolution XPS spectrum of N 1s. The three characteristic peaks at 398.5, 399.2, and 400.6 eV were attributed to the action of C=N-C, N-(C)₃, and C-N-H bonds, respectively.²¹ The escape of N atoms in the amino group on the surface of $g\text{-C}_3\text{N}_4$ is much easier to accomplish than other N atoms; therefore, the number of amino functional groups is consistent with the number of nitrogen defects.²² The proportions of the C-N-H peak areas $g\text{-C}_3\text{N}_4$ was untreated and treated with plasma were 27.35% and 18.70%, respectively. It indicates



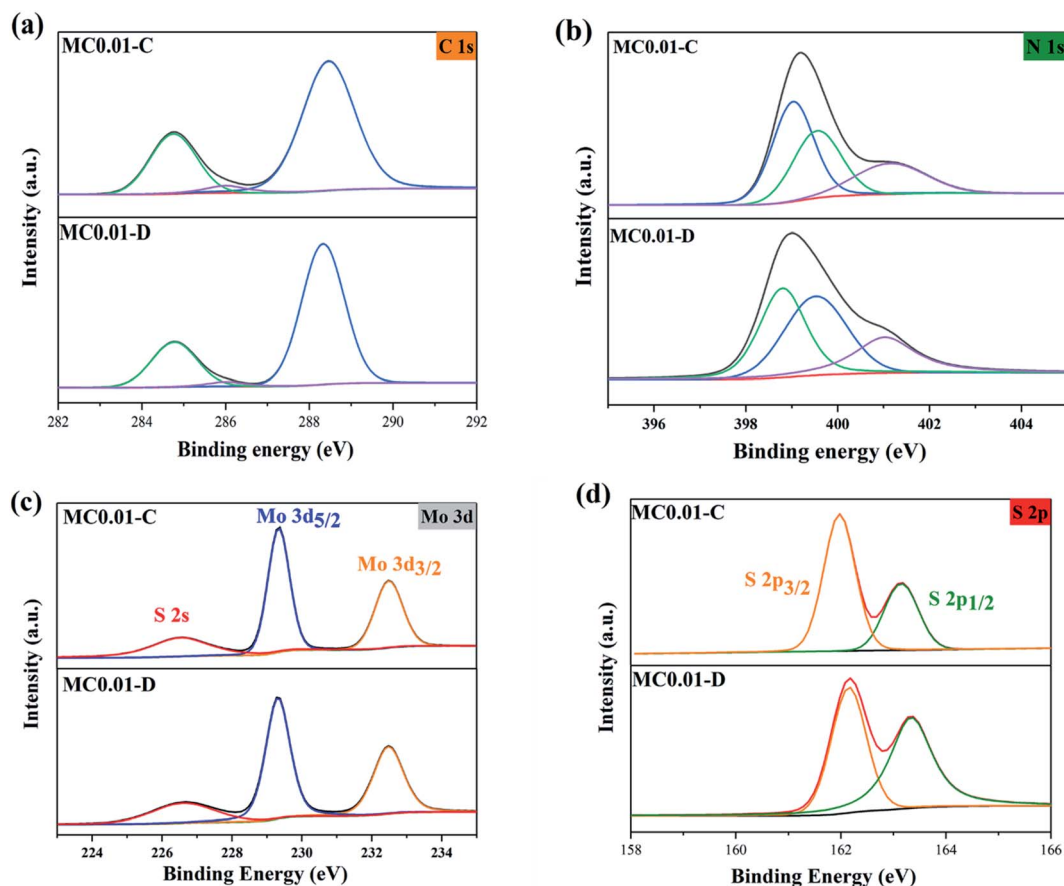


Fig. 3 High-resolution XPS spectra of the (a) C 1s, (b) N 1s, (c) Mo 3d, and (d) S 2p of MC0.01-C and MC0.01-D.

that N vacancies were generated on the surface of $g\text{-C}_3\text{N}_4$ by electron bombardment.

Fig. 2b shows the high-resolution XPS spectrum of C 1s. The peaks at 284.8, 255.6, and 288.4 eV are attributed to N-(C)_3 , $\text{C}=\text{N}$, and C-C respectively.²³ The peak area representing the $\text{C}=\text{N}$ bond decreased after plasma treatment. This result also indicates the successful generation of N vacancies. In summary, the chemical structure of $g\text{-C}_3\text{N}_4$ did not change by plasma, but N vacancies were produced on the surface of $g\text{-C}_3\text{N}_4$ under plasma etching.

The statistics of C/N atomic ratio were showed the absence of N atoms. Table 1 shows the changes of the C/N atomic ratio of $g\text{-C}_3\text{N}_4$ and MC0.01 before and after plasma treatment. The C/N atomic ratio of $g\text{-C}_3\text{N}_4$ after plasma treatment was changed from 0.921 to 0.954, which indicates the absence of N atoms. MC0.01-D also exhibited a C/N atomic ratio of 0.969, which is smaller than the C/N atomic ratio of the MC0.01-C (0.976). It indicates that plasma is efficient method for producing defects. The C/N atom ratio of the composites was slightly larger than that of pure $g\text{-C}_3\text{N}_4$ because of the MoS_2 and $g\text{-C}_3\text{N}_4$ are closely combined.

The XPS spectra of MC0.01-C and MC0.01-D are shown in Fig. 3. Fig. 3a and b show the high-resolution XPS spectra of C 1s and N 1s, respectively. The main characteristic peaks are similar to those of $g\text{-C}_3\text{N}_4$. Interestingly, the differences of the peak

areas between the $\text{C}=\text{N}$ and C-N-H groups of the composite were not as large as those of pure $g\text{-C}_3\text{N}_4$ after plasma treatment. It is because MoS_2 occupies the surface of $g\text{-C}_3\text{N}_4$ in the composite. As shown in Fig. 3c, the two characteristic peaks at 229.2 and 232.5 eV correspond to Mo 3d_{5/2} and Mo 3d_{3/2}, respectively, which indicates that Mo is as Mo^{4+} .²⁴ The peak at 226.6 eV corresponds to S 2s. Fig. 3d shows the characteristic peaks of S 2p_{3/2} and S 2p_{1/2}, which are located at 162 and 163.5 eV, respectively.²⁵ $(\text{NH}_4)_2\text{MoS}_4$ was successfully reduced to MoS_2 by the plasma and successfully loaded on $g\text{-C}_3\text{N}_4$.

The defects of $g\text{-C}_3\text{N}_4$ and MoS_2 were explored by EPR to investigate $g\text{-C}_3\text{N}_4$ and MoS_2 samples by plasma treatment. As shown in Fig. 4a, $g\text{-C}_3\text{N}_4$ shows a signal peak at $g = 2.003$, which can be attributed to unpaired electrons on the sp^{2-} carbon atoms of the aromatic rings within π bonds.²⁶ Extra electrons remaining after the escape of N atoms could affect delocalized carbon atoms between π bonds and result in the formation of more asymmetric electrons.²⁶ The peak intensity increased after plasma treatment; thus, more N vacancies were generated by plasma treatment. According to Fig. 4b, both plasma treated and untreated MoS_2 samples have characteristic peaks of ~ 3500 G, and the MoS_2 prepared by plasma has weaker peak intensity than that prepared by calcination. This characteristic peak can be attributed to the presence of dangling Mo-S bonds. A higher peak intensity indicates a lower concentration of S vacancies.²⁷

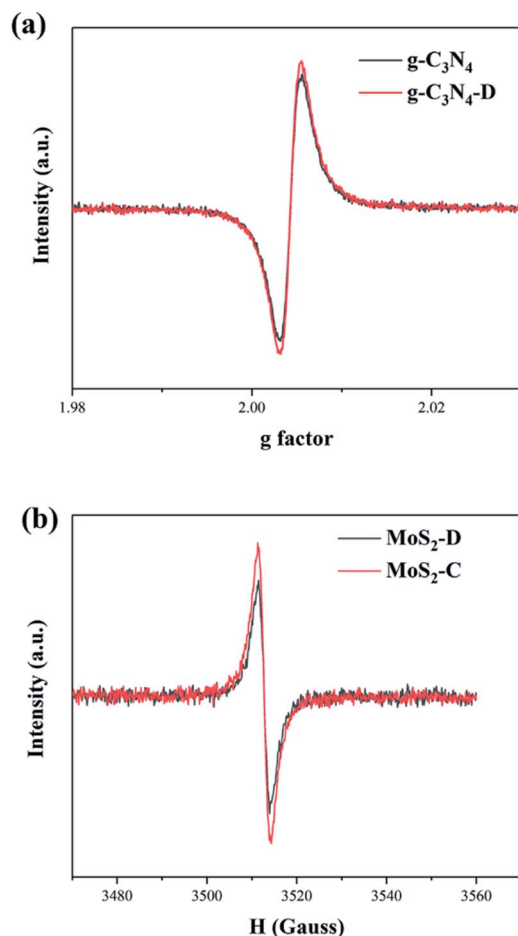


Fig. 4 EPR spectra of (a) $g\text{-C}_3\text{N}_4$ and (b) MoS_2 .

Therefore, $\text{MoS}_2\text{-D}$ has more S vacancies than that of $\text{MoS}_2\text{-C}$. The sample obtained by plasma treatment has a high concentration of S vacancies, which plays a key role in improving its photocatalytic performance. The existence of N and S vacancies also provides strong interaction for the combination of $g\text{-C}_3\text{N}_4$ and MoS_2 .

The results of XRD, XPS and EPR strongly proved that the N and S defects on the $g\text{-C}_3\text{N}_4/\text{MoS}_2$ surface were successfully introduced with the assistance of plasma. The defect generation mechanism could be explained as: during the plasma discharge, Ar and H_2 were ionized into Ar^* and H^* , and produced a lot of high-energy electrons. During the process, S in the MoS_2 lattice was bombarded by Ar^* and e^- , causing it to escape from the lattice and leaving S vacancies.²⁸ The N in the C_3N_4 lattice escaped by e^- bombardment and was captured by H^* to form ammonia, forming a stable N vacancy on the crystal surface,²⁹ thereby reducing the coordination number of C in the two coordination environments of C–N–H and C=N–C. More importantly, the defect introduction strategy assisted by electrons could efficiently construct defect sites without damaging the crystal structure, which proved that plasma is a gentle and efficient way to construct vacancies.

The morphological characteristics of MC0.01 composites were analyzed by scanning electron microscopy (SEM). As

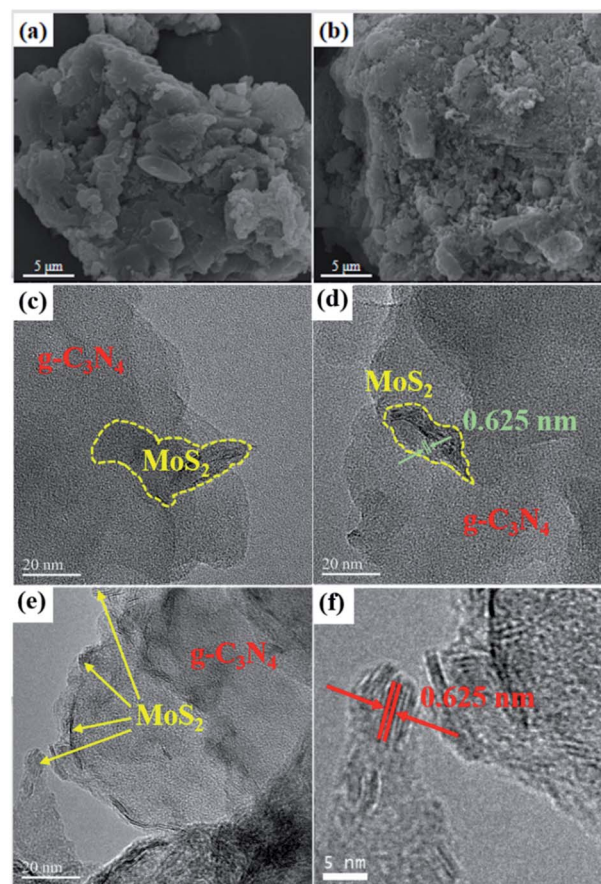


Fig. 5 SEM images of (a) MC0.01-C and (b) MC0.01-D. (c–f) HRTEM images of MC0.01-D.

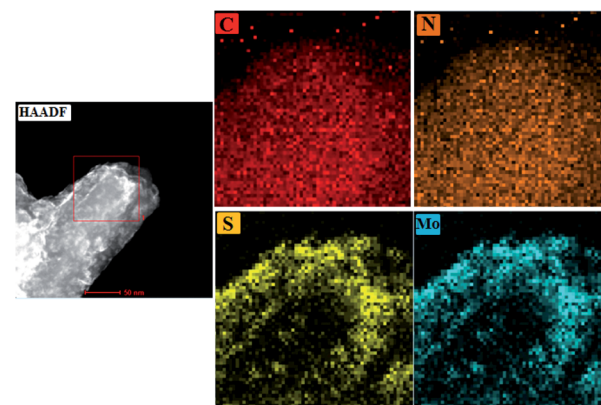


Fig. 6 STEM-EDX elemental mapping of MC0.01-D.

shown in Fig. 5a, the sample shows the layered structure, which is typical of $g\text{-C}_3\text{N}_4$. Fig. 5b shows that the surface of the plasma-treated sample is rougher than that of the calcinated sample because of electron impact. It confirms that plasma etching is the main reason for the production of defects.

A high-resolution TEM image of MC0.01-D is shown in Fig. 5c–f. As shown in Fig. 5c and 6d, $g\text{-C}_3\text{N}_4$ has a large sheet-like structure with several stacked layers, while MoS_2 shows



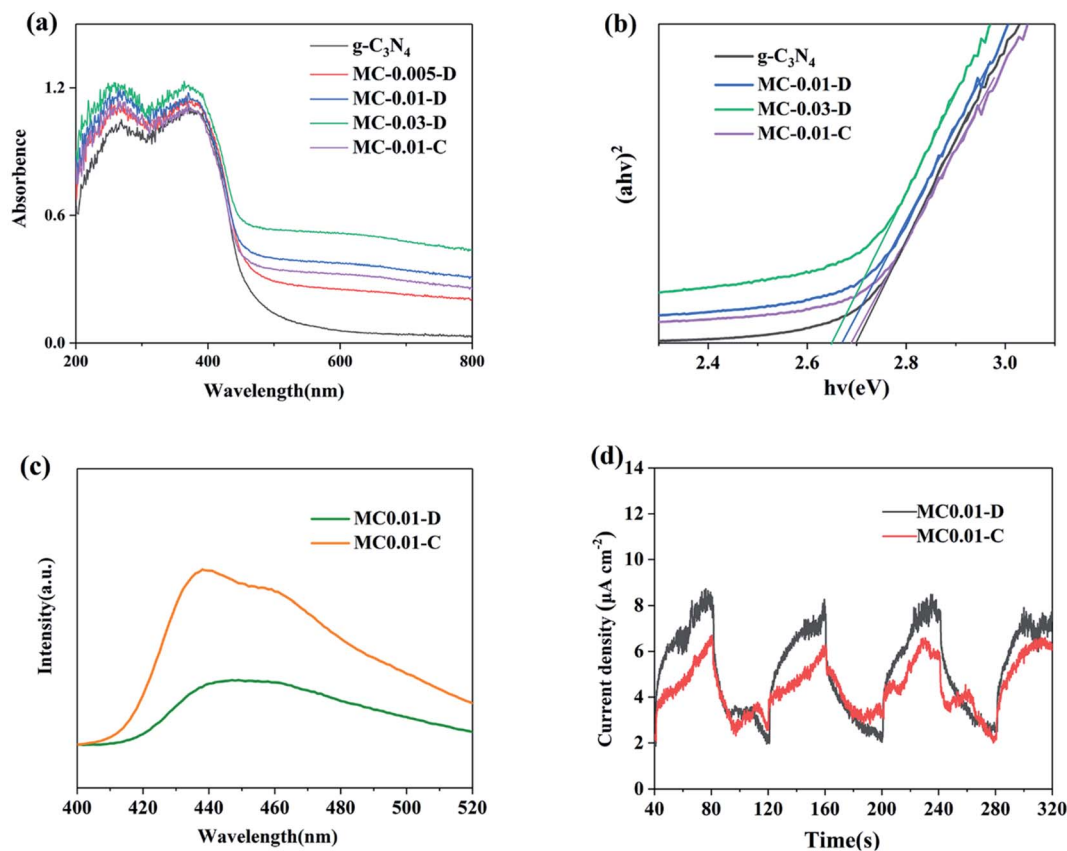


Fig. 7 (a) UV-vis DRS and (b) the relationship between $(ah\nu)^2$ and $h\nu$ of $g\text{-C}_3\text{N}_4$ and $g\text{-C}_3\text{N}_4/\text{MoS}_2$ composites. (c) PL spectra and (d) photocurrent density curve of MC0.01-D and MC0.01-C.

smaller nanosheets loaded on $g\text{-C}_3\text{N}_4$. It indicates that MoS_2 nanosheets were successfully loaded onto $g\text{-C}_3\text{N}_4$ by plasma treatment that formed a heterogeneous interface. The strong interaction can facilitate charge transfer and improve the efficiency of charge analysis. As shown in Fig. 5e, MoS_2 lattice fringes appeared at the edge of $g\text{-C}_3\text{N}_4$; thus, MoS_2 was loaded on the surface layer of $g\text{-C}_3\text{N}_4$. Fig. 5f presents a high-resolution image of these lattice fringes. The width of the lattice is 0.625 nm, which corresponds to the (002) crystal plane of MoS_2 .

Scanning transmission electron microscopy with energy-dispersive X-ray spectroscopy (STEM-EDX) elemental mapping analysis was performed to explore the distribution of the composite elements. Fig. 6 shows that the C and N elements are densely and uniformly distributed, whereas the S and Mo elements are distributed on the edge positions. It is consistent with the results of HRTEM.

The UV-visible diffuse reflection spectrum (UV-vis DRS) of the samples is shown in Fig. 7a. The graph converted by the Kubelka-Munk algorithm function is shown in Fig. 7b to reveal the band gap of the material more accurately. The visible light absorption edge of pure $g\text{-C}_3\text{N}_4$ is located at 460 nm, and its corresponding band gap width is 2.70 eV.³⁰ The visible light absorption range of the composites gradually expanded as increasing of MoS_2 . MC0.03-D exhibited a maximum absorption edge of 483 nm and a corresponding band gap width of 2.65 eV.

Light response intensity also increased in the range of 450–800 nm with increasing of MoS_2 . The band gaps of MC0.01-D and MC0.01-C were 2.67 and 2.69 eV, respectively. Thus, plasma-sample has better light absorption ability than calcination-sample due to more N and S vacancies. The vacancies change the electronic structure and promote the light absorption ability of the as-prepared materials^{8a,17}

Photoluminescence (PL) spectroscopy was performed to investigate the charge recombination of the samples. The PL peak intensity is negatively correlated with the electron-hole separation efficiency of a material.^{3a} As shown in Fig. 7c, MC0.01-D has a lower peak intensity, which means it has a higher electron-hole separation efficiency,³¹ compared with MC0.01-C. The large number of vacancies increases the donor energy level of the material and promotes the efficiency of charge separation.³² The photocurrent density curve in Fig. 7d shows that MC0.01-D can produce a higher current density than MC0.01-C under the same light conditions; current density directly affects the extent of photocatalytic reaction. In summary, the vacancies improve the light absorption ability and the charge separation efficiency of the material, thereby enhancing its photocatalytic performance.

Organic pollutants were degraded under visible light to evaluate the photocatalytic activity of the prepared samples. Fig. 8a shows the photocatalytic degradation of RhB by $g\text{-C}_3\text{N}_4$

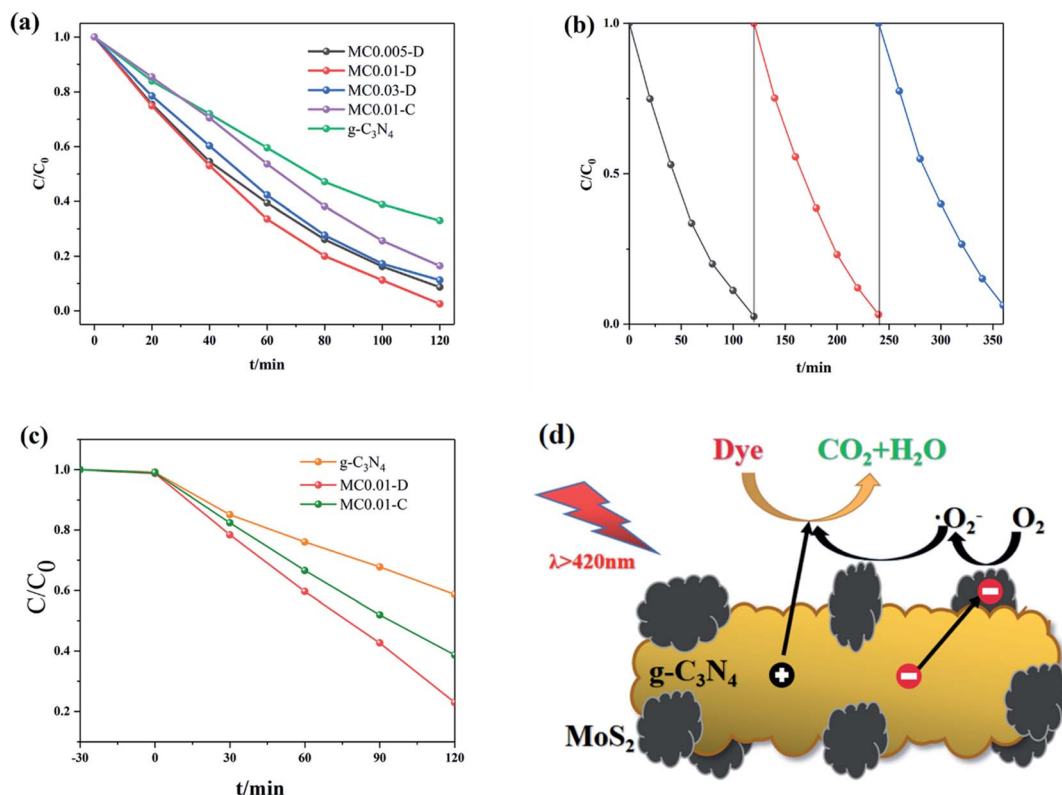


Fig. 8 (a) Photocatalytic degradation of RhB by g-C₃N₄ and g-C₃N₄/MoS₂ samples under visible light irradiation. (b) Photodegradation stability of RhB over MC0.01-D. (c) Photocatalytic degradation of MO by g-C₃N₄ and MC0.01 under visible light irradiation. (d) Mechanism of the photocatalytic degradation of dyes by g-C₃N₄/MoS₂ composites.

and g-C₃N₄/MoS₂ under visible light irradiation. The pure g-C₃N₄ showed the lowest photocatalytic activity, and its degradation rate reached 64% within 2 h. The photocatalytic activity of the composites improved with increasing MoS₂ loading because the interface between MoS₂ and g-C₃N₄ promote charge transport. The photocatalytic degradation activity of the composite was highest when its MoS₂ loading was 1%. Degradation on MC0.01-D was completed within 2 h. The activity of the composites decreased when the MoS₂ loading was further increased because of a decrease of active sites on surface of g-C₃N₄. It shows that an appropriate loading amount is necessary to achieve optimal activity.³³ The degradation efficiency of MC0.01-C was 79% within 2 h, which is much lower than that of MC0.01-D. MC0.01-D has an abundance of N and S vacancies that promote light absorption and charge separation.

The stability of the samples was also investigated in photodegradation of RhB. As shown in Fig. 8b, the degradation rate of the samples decreased slightly after three cycles of degradation. It indicates that the composites prepared by plasma have strong stability. The prepared samples were also applied to the photocatalytic degradation of MO. As shown in Fig. 8c, MC0.01-D has higher activity than MC0.01-C. It also confirms the previous results.

The mechanism of the photocatalytic degradation of dyes on g-C₃N₄/MoS₂ composites is shown in Fig. 8d. Electrons and holes were generated on g-C₃N₄ when exposed to light. The

conduction band of g-C₃N₄ is more negative compared with the conduction band of MoS₂; hence, electrons can be transferred from the conduction band of the former to that of the latter.⁶ These electrons react with surface adsorbed oxygen to generate superoxide radicals.³⁴ ·O₂⁻ plays a key role in degrading dye. Holes in g-C₃N₄ are directly transported to the surface of the samples to react with the dye. At the same time, the existence of N vacancies caused the distance between adjacent C atoms to be significantly shortened, forming new C–C bonds, thereby significantly changing the surface electronic structure.³⁵ And after the formation of N defects, the Fermi level moves to the bottom of the conduction band, which makes the material exhibit metallic properties and significantly reduces the band gap.³⁵ Furthermore, the introduction of S vacancies would cause MoS₂ to exhibit a transition from an indirect to a direct band gap, thereby further reducing the charge transfer resistance.³⁶ Finally, organic dyes are degraded into CO₂ and H₂O. So, the N and S defects on g-C₃N₄/MoS₂ composites, which facilitates the recombination and formation of heterojunction. It helps light absorption and charge transfer in photocatalytic degradation.

Conclusions

g-C₃N₄/MoS₂ composites were prepared *via* an environment-friendly and efficient electron assisted plasma technology. The heterogeneous interface between g-C₃N₄ and MoS₂ promotes charge transfer and improves photocatalytic performance of the



composite. Plasma etching produces an abundance of N and S vacancies on the surface of g-C₃N₄/MoS₂. These vacancies increased the light absorption capacity of the composite and improved their charge separation efficiency. The photocatalytic degradation efficiency of the composite by plasma was highest when the MoS₂ was loaded 1 wt%, and the composite completely degrade organic pollutants within 2 h. Plasma technology has unique advantages in produce defects and preparation of heterostructured composites with prospective application as photocatalysts for pollutant degradation.

Author contributions

Jingxuan Zheng: conceptualization, data curation, formal analysis. Bo Zhang: investigation, writing – original draft. Zhao Wang: supervision, writing – review & editing.

Conflicts of interest

There are no conflicts to declare.

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